

Notice of References Cited	Application/Control No. 10/531,050	Applicant(s)/Patent Under Reexamination HIRANO ET AL.	
	Examiner David Mis	Art Unit 2817	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,834,084	12-2004	Hietala, Alexander Wayne	375/296
*	C	US-7,075,376	07-2006	Huff et al.	331/23
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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